



**PATENT APPLICATION**

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re application of

Docket No: Q80643

Yuichi KOMACHI, et al.

Appln. No.: 10/807,265

Group Art Unit: 2877

Confirmation No.: 4118

Examiner: Not Yet Assigned

Filed: March 24, 2004

For: RAMAN PROBE AND RAMAN SPECTRUM MEASURING APPARATUS UTILIZING  
THE SAME

**SUBMISSION OF PRIORITY DOCUMENT**


Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

Submitted herewith is a certified copy of Japanese Patent Application No. 2003-083318,  
the priority document on which a claim to priority was made under 35 U.S.C. § 119. The  
Examiner is respectfully requested to acknowledge receipt of said priority document.

Respectfully submitted,

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**23373**

CUSTOMER NUMBER

Enclosure: Japanese Patent Application No. 2003-083318

Date: July 30, 2004



(Translation)

PATENT OFFICE  
JAPANESE GOVERNMENT

This is to certify that the annexed is a true copy of the following application as  
filed with this Office.

Date of Application: March 25, 2003

Application Number: Japanese Patent Application  
No. 2003-083318

Applicant(s): RIKEN  
MACHIDA ENDOSCOPE CO., LTD.

May 11, 2004

Commissioner,  
Patent Office

Yasuo IMAI (seal)

Certificate No. 2004-3039222